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(12) **United States Design Patent**
Zhang et al.

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- (54) **DIGITAL MICROMETER**
- (71) Applicants: **Yanchen Zhang**, San Clemente, CA
(US); **Meng Zhang**, San Clemente, CA
(US)
- (72) Inventors: **Yanchen Zhang**, San Clemente, CA
(US); **Meng Zhang**, San Clemente, CA
(US)

7,266,906 B2 * 9/2007 Suzuki G01B 3/18
33/784
8,091,251 B1 * 1/2012 Zhang G01B 3/18
33/819

* cited by examiner

Primary Examiner — Antoine Duval Davis
(74) *Attorney, Agent, or Firm* — Let Z. Kwan, Esq.

(**) Term: **15 Years**

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(51) **LOC (11) Cl.** **10-04**

(52) **U.S. Cl.**
USPC **D10/73**

(58) **Field of Classification Search**
USPC D10/73
CPC G01B 3/18
See application file for complete search history.

(56) **References Cited**

U.S. PATENT DOCUMENTS

- 3,667,127 A * 6/1972 Tsugami G01B 3/18
33/704
- D429,172 S * 8/2000 Reymond D10/73

(57) **CLAIM**

The ornamental design for a digital micrometer, as shown and described.

DESCRIPTION

FIG. 1 is a top, right perspective view of a digital micrometer showing our new design;
FIG. 2 is a left side view thereof;
FIG. 3 is a top plan view thereof;
FIG. 4 is a bottom plan view thereof;
FIG. 5 is a right side view thereof;
FIG. 6 is a head on view thereof; and,
FIG. 7 is a rear end view thereof.

1 Claim, 4 Drawing Sheets

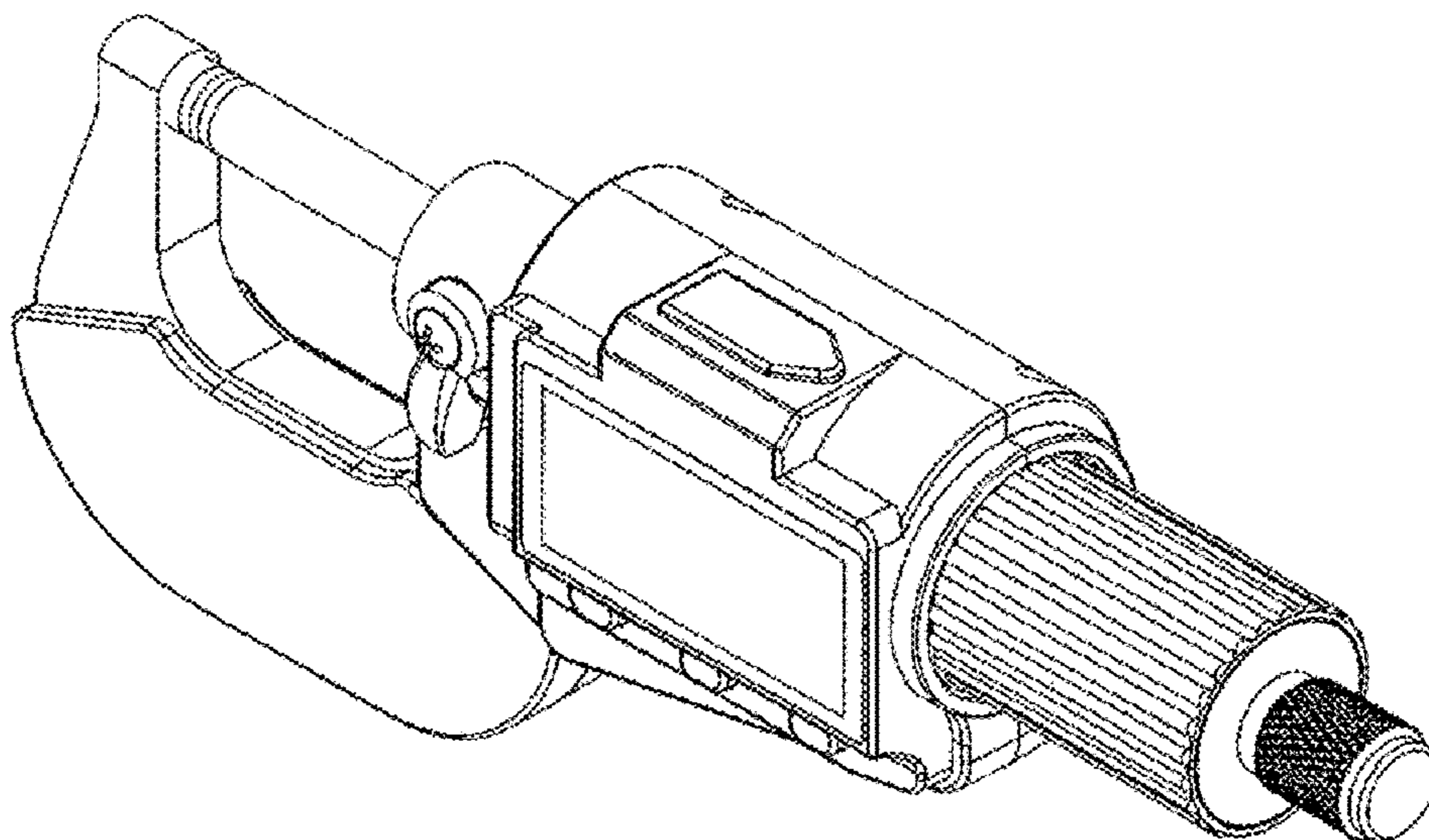
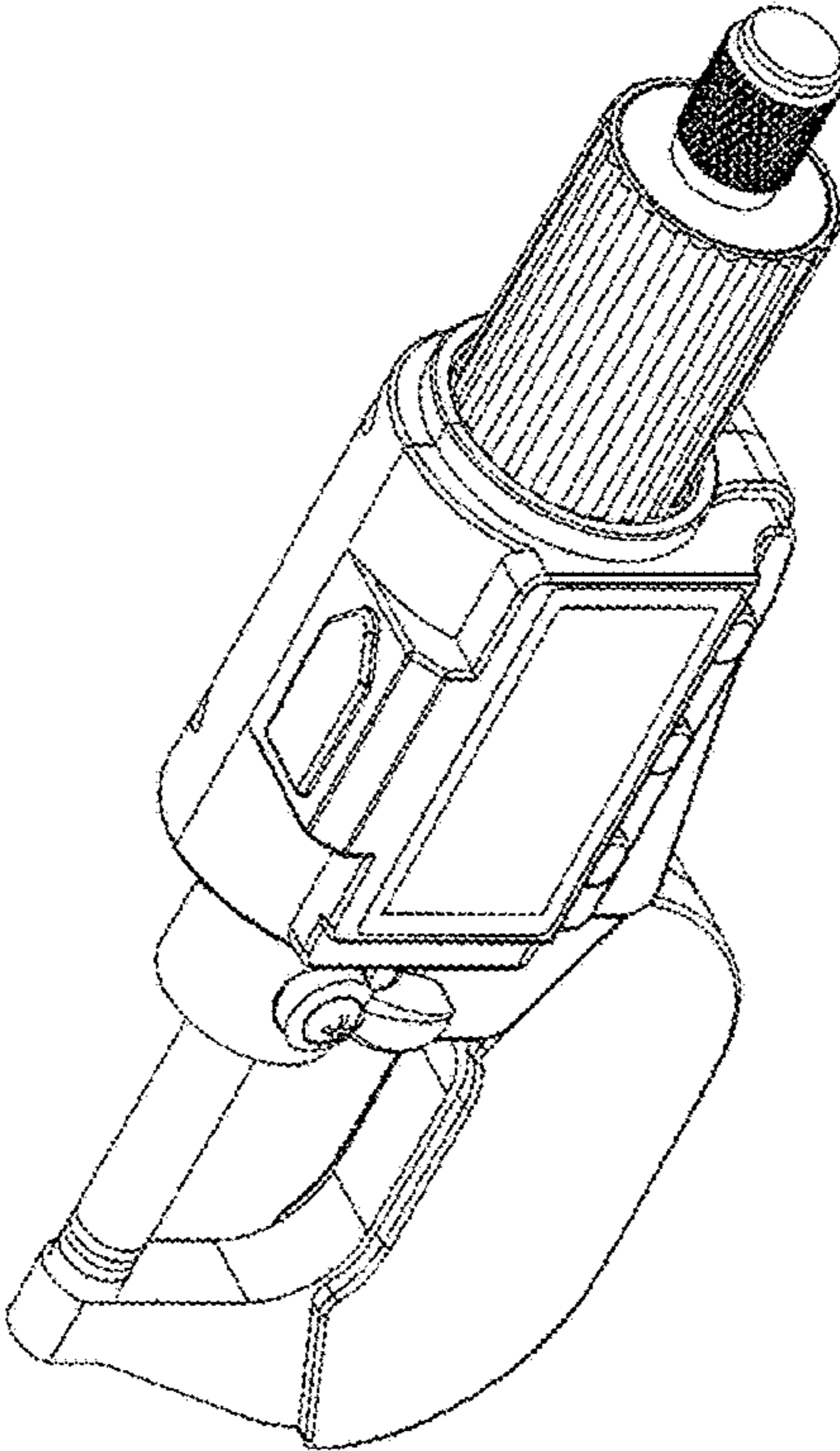


Fig. 1



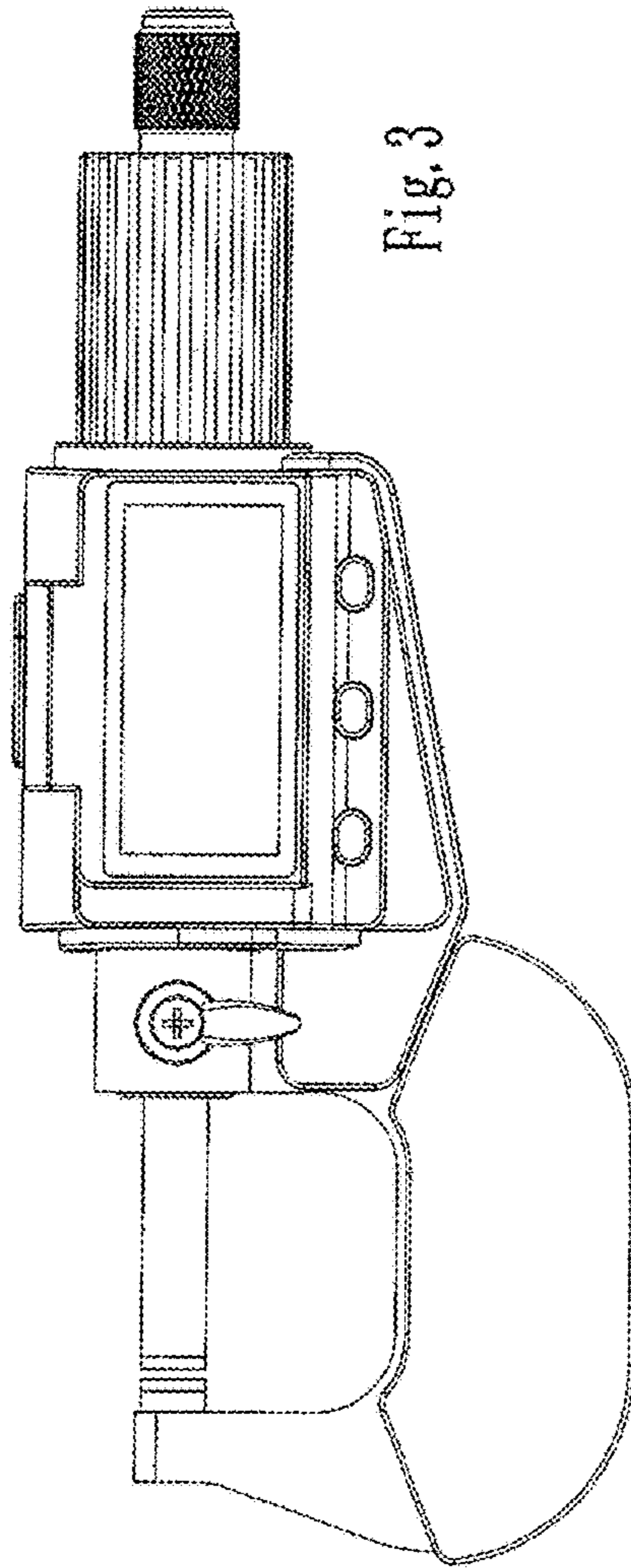


Fig. 3

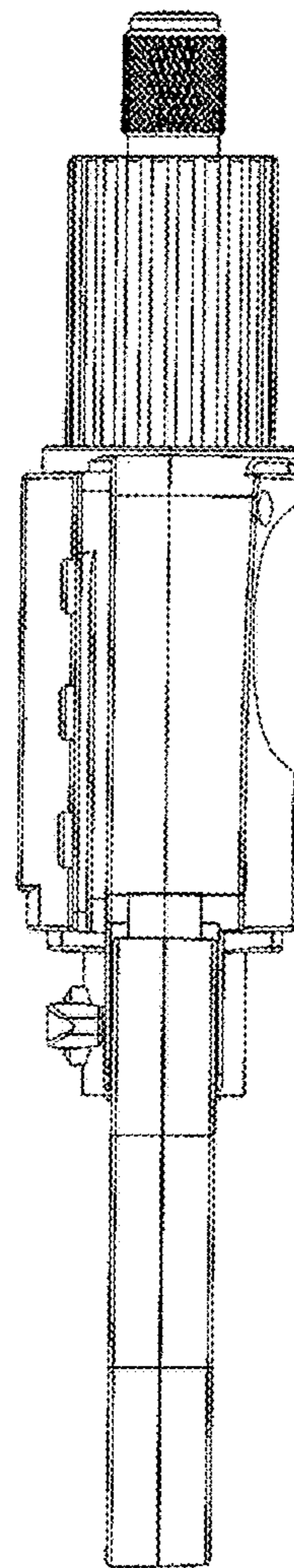
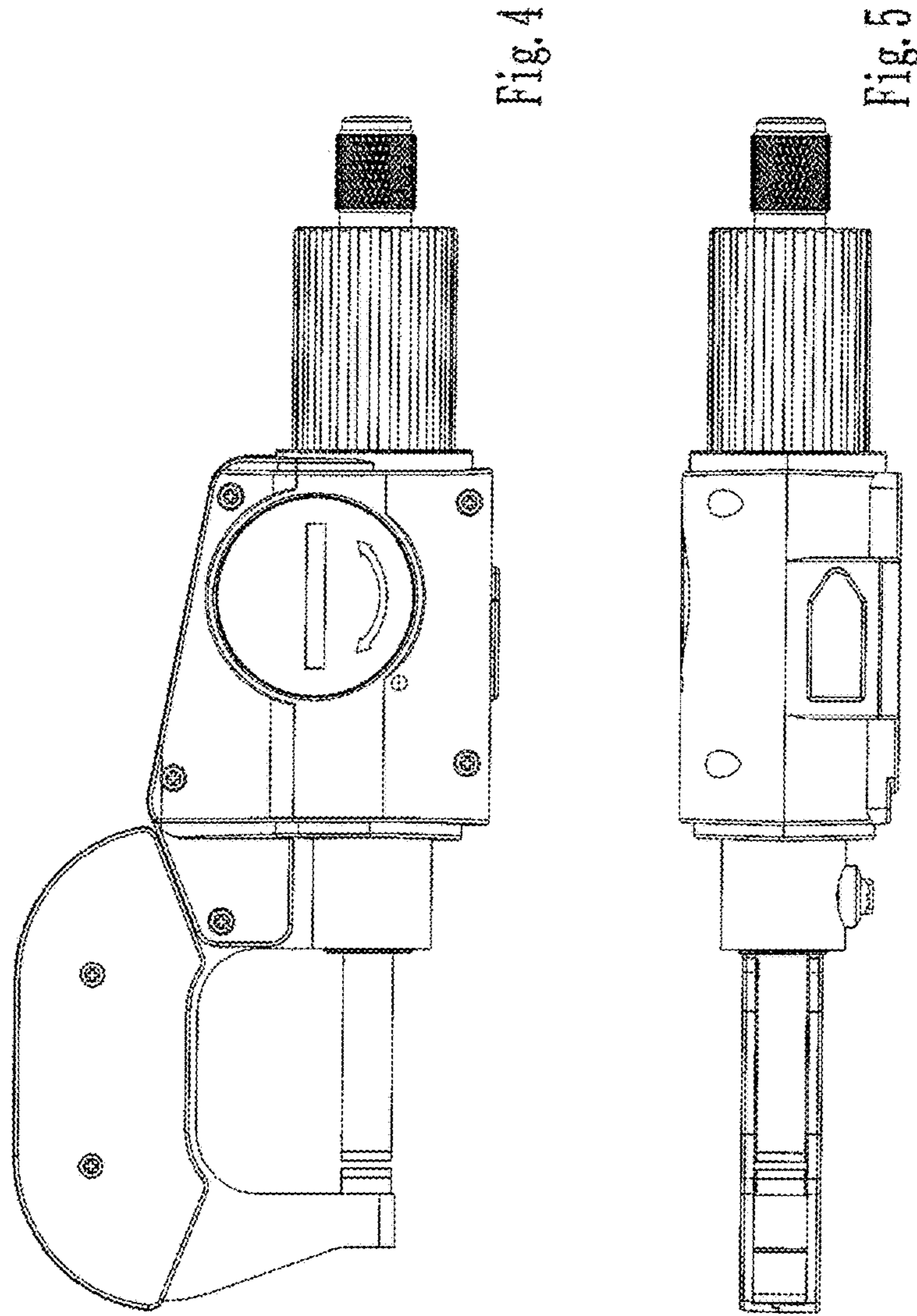


Fig. 2



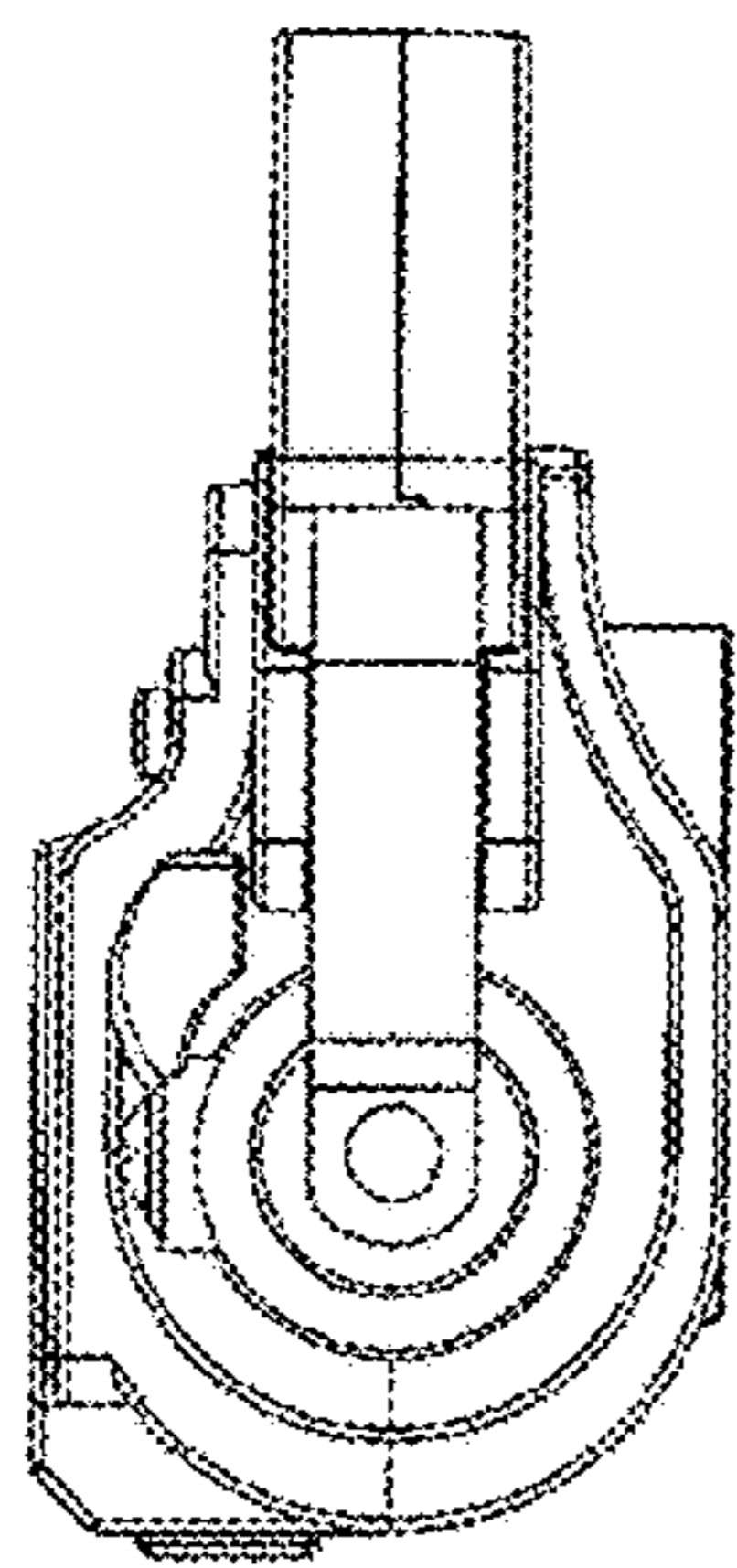


Fig. 6

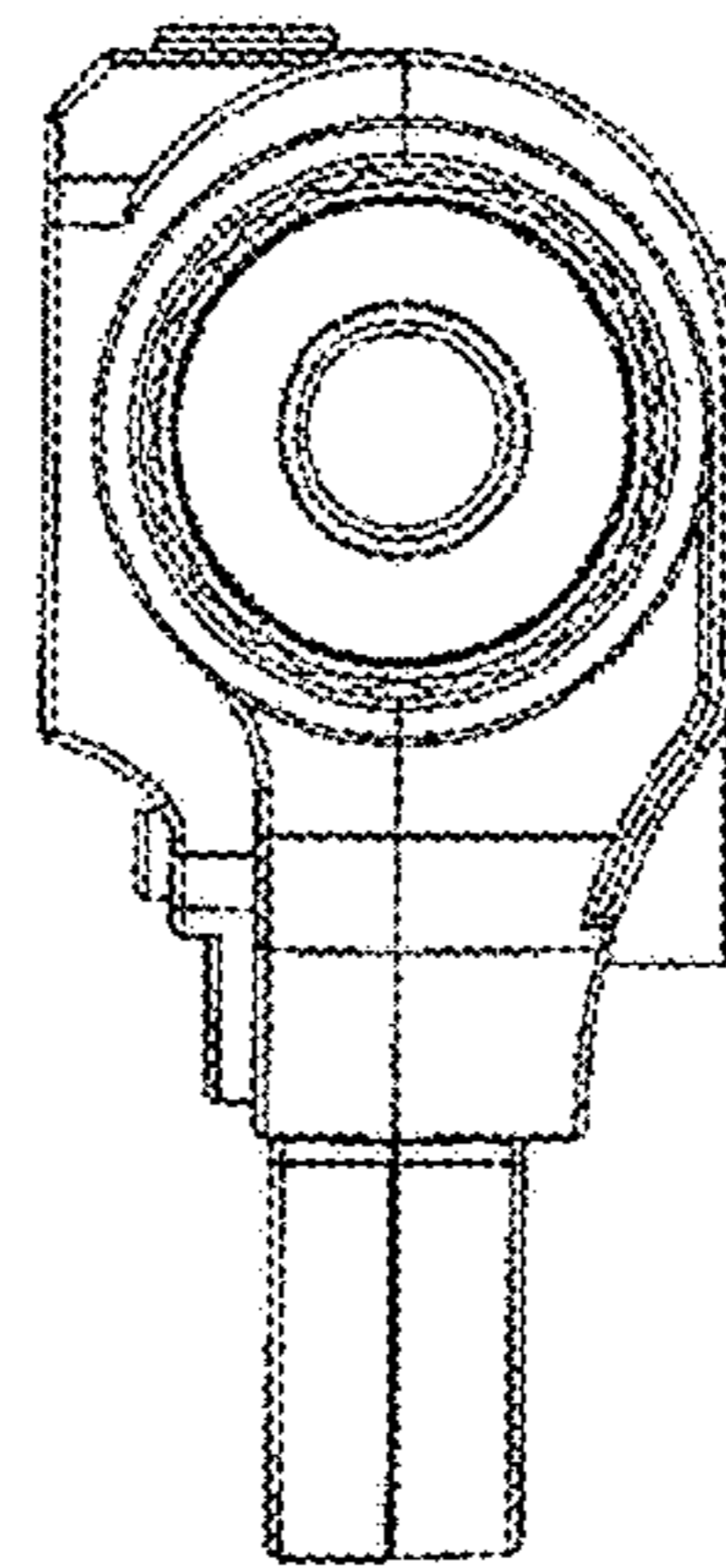


Fig. 7